Search Notes		
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Application No.	Applicant(s)	
10/008,192	ADAMS ET AL.	
Examiner	Art Unit	
Ouoc A Tran	2176	

SEARCHED			
Class	Subclass	Date	Examiner
715	513	6/15/2005	QT
707	1	6/15/2005	QT
709	217	6/15/2005	QT

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Inventor searcg check for double patent, US-PAT, US-PGPUB, EPO, JPO, Derwent, IBM_TDB, Internet search, Plus search, EIC	6/15/2005	QT
Personal Digests	6/15/2005	QT
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